

## NCE N-Channel Enhancement Mode Power MOSFET

#### **Description**

The NCE6009XS uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

#### **General Features**

V<sub>DS</sub> = 60V,I<sub>D</sub> =9A

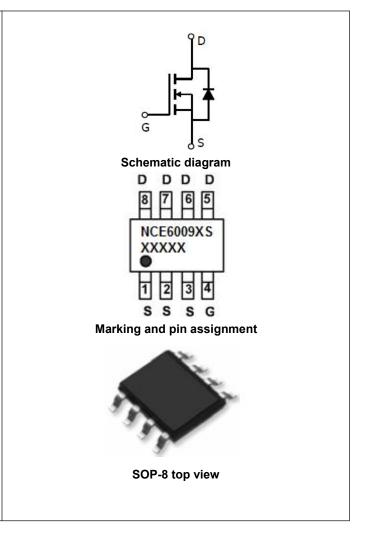
 $R_{DS(ON)} < 11 m\Omega @ V_{GS} = 10V \quad (Typ:9.3 m\Omega)$ 

 $R_{DS(ON)} < 15m\Omega$  @  $V_{GS}=4.5V$  (Typ:12.7m $\Omega$ )

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Low gate to drain charge to reduce switching losses

### **Application**

- Power switching application
- Load switch



## **Package Marking and Ordering Information**

	<u> </u>				
Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
NCE6009XS	NCE6009XS	SOP-8	_	-	-

#### Absolute Maximum Ratings (T<sub>c</sub>=25℃unless otherwise noted)

<b>5</b> \ \ -	,	,			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	60	V		
Gate-Source Voltage	V <sub>G</sub> s	±20	V		
Drain Current-Continuous	I <sub>D</sub>	9	А		
Drain Current-Continuous(T <sub>C</sub> =100 °C)	I <sub>D</sub> (100°C)	6.4	А		
Pulsed Drain Current	I <sub>DM</sub>	36	А		
Maximum Power Dissipation	P <sub>D</sub>	2.6	W		
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	°C		

#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	48	°C/W

## Electrical Characteristics (TC=25℃unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	1					
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	60		-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =60V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}=\pm20V, V_{DS}=0V$	-	-	±100	nA
On Characteristics (Note 3)						•
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	1.2	1.8	2.2	V
D : 0		V <sub>GS</sub> =10V, I <sub>D</sub> =9A	-	9.3	11	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =9A	-	12.7	15	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =5V,I <sub>D</sub> =9A	25	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>		-	2750	-	PF
Output Capacitance	Coss	$V_{DS}=30V, V_{GS}=0V,$	-	170	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.0MHz	-	152	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t <sub>d(on)</sub>		-	9	-	nS
Turn-on Rise Time	tr	$V_{DD}$ =30V, $R_L$ =1 $\Omega$	-	7	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}\text{=}10V, R_{GEN}\text{=}3\Omega$	-	32	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	6	-	nS
Total Gate Charge	Qg	\/ 00\/ L 0A	-	60	-	nC
Gate-Source Charge	Qgs	$V_{DS}=30V,I_{D}=8A,$	-	10	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =10V	-	14	-	nC
Drain-Source Diode Characteristics	- 1					
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =9A	-	-	1.2	V
Diode Forward Current (Note 2)	Is	-	-	-	9	Α
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, IF=9A	-	30	-	nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	44	-	nC

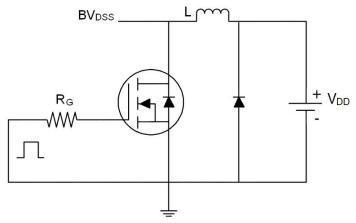
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

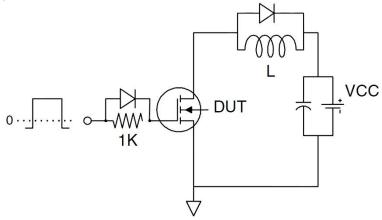


## **Test Circuit**

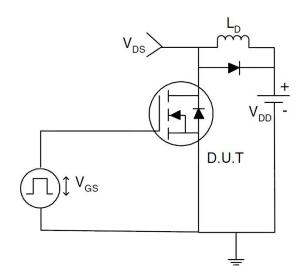
## 1) E<sub>AS</sub> test Circuit



## 2) Gate charge test Circuit

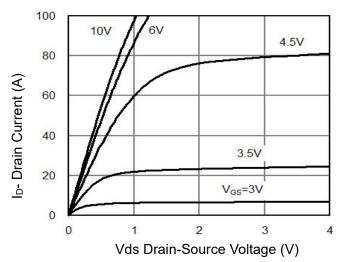


## 3) Switch Time Test Circuit

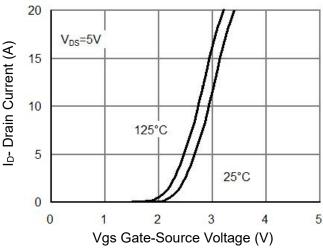




## **Typical Electrical and Thermal Characteristics (Curves)**



**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

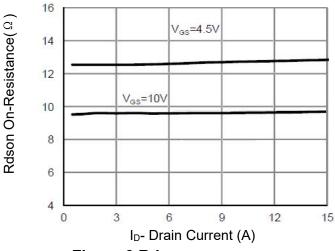


Figure 3 Rdson- Drain Current

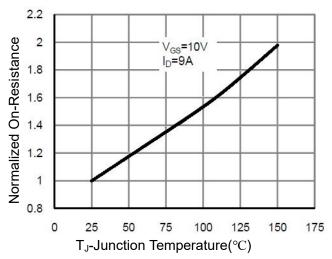


Figure 4 Rdson-JunctionTemperature

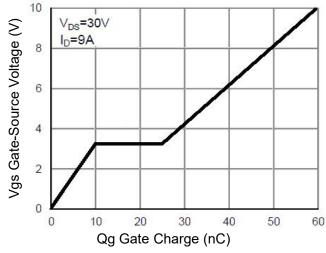


Figure 5 Gate Charge

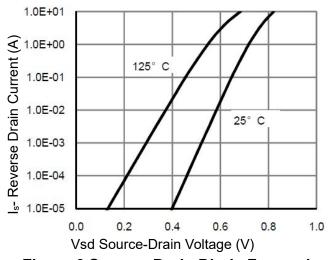
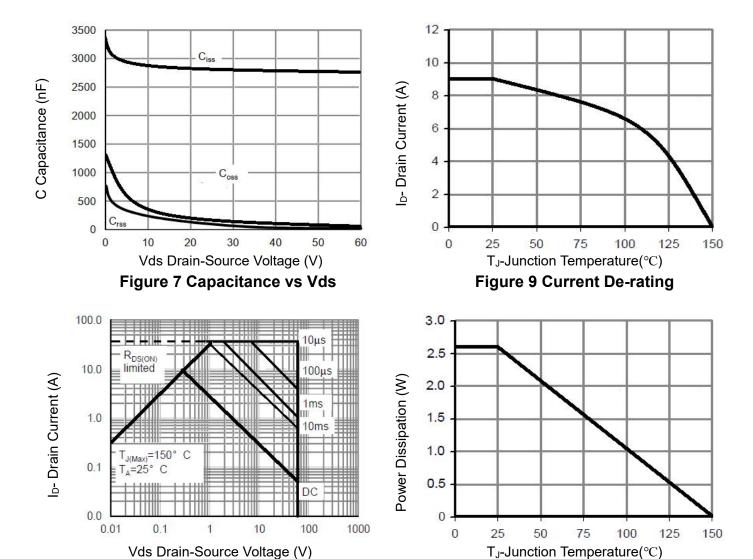


Figure 6 Source- Drain Diode Forward





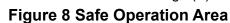
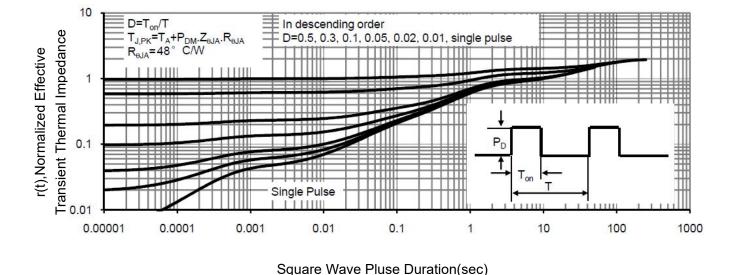


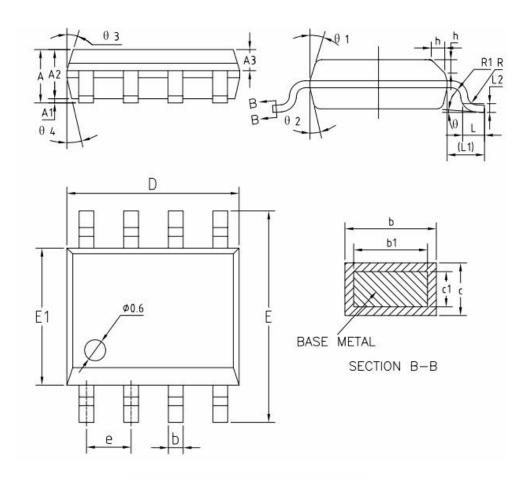
Figure 10 Power De-rating



**Figure 11 Normalized Maximum Transient Thermal Impedance** 



# **SOP-8 Package Information**



COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX	
Α	1.35	1.55	1.75	
A1	0.10	0.15	0.25	
A2	1.25	1.40	1.65	
A3	0.50	0.60	0.70	
b	0.38	_	0.51	
b1	0.37	0.42	0.47	
С	0.18	_	0.25	
c1	0.17	0.20	0.23	
D	4.80	4.90	5.00	
E	5.80	6.00	6.20	
E1	3.80	3.90	4.00	
е	1.17	1.27	1.37	
L	0.45	0.60	0.80	
L1	1.04REF			
L2	0.25BSC			
R	0.07	-	1 - 1	
R1	0.07	-	-	
h	0.30	0.40	0.50	
θ	0.	-	8.	
θ 1	15*	17*	19"	
9.2	11*	13*	15°	
θ3	15°	17*	19*	
θ 4	11'	13°	15*	

#### http://www.ncepower.com

# NCE6009XS

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